

Search Notes				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/656,409	D'AGUANNO, FRANCIS D.	
				Examiner	Art Unit	
				Randall Chin	1744	

SEARCHED			
Class	Subclass	Date	Examiner
15	185		
15	236.01		
15	236.05		
15	236.06		
15	236.07		
15	236.08		
15	236.09		
30	153		
30	255		
7	128		
81	177.6		
81	177.7	✓	✓
81	427.5	9/18/2006	RC
UPDATED	SREH	4/18/07	RE

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST, OCR, EPO, JPO, DERWENT		
Inventor name search		
Hwei-Siu Payer, Cl..30 search	✓	✓
Debra Meislin, Cl. 7 and 81 search	9/18/2006	RC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner